

Traceability Japan TC Chapter

Thursday, December 15, 2022

OVTCCM / SEMICON Japan @Tokyo Big Sight, Room 703, 7F, Conference Tower, Tokyo, Japan (Hybrid)
15:30 – 16:30

AGENDA

SVM Software (for voting) ※SVM へのログインもお願いします。

1. Open a Web browser and go to: <https://svm.semi.org/> (Do not use Internet Explorer or MS Edge)
2. Click “Login”
3. Enter your Standards Membership username and password (same login for voting on ballots).
4. If you have forgotten your username and/or password, they may be retrieved at: <https://ams.semi.org/ebusiness/ForgotUID.aspx>
5. Find the meeting room: < Traceability JA TC Chapter, December 15, 2022 >
6. Click “Go

1.0 Welcome / Call to Order

- 1.1 Introductions
- 1.2 Meeting Reminders (*Membership Requirement, Antitrust and Intellectual Property Reminders, Effective Meeting Guidelines*)
- 1.3 Agenda Review

2.0 Review and Approval of Previous Meeting Minutes

3.0 Liaison Report

- 3.1 North America TC Chapter

4.0 Staff Report

5.0 Ballot Review

- 5.1 Doc.6935 - Reapproval of SEMI T19-0311 (Reapproved 0717): Specification for Device Marking

6.0 Subcommittee & Task Force Reports

- 6.1 5 Year Review Task Force
- 6.2 Japan Single Device Traceability (SDT) liaison TF
- 6.3 Japan Equipment and Materials Traceability (EMT) liaison TF
- 6.4 Panel Level Packaging (PLP) Glass Carrier ID Marking Task Force
- 6.5 Blockchain TF

7.0 Old Business

- 7.1 5 Year Review Check
- 7.2 SNARF Project Period Check

8.0 New Business

9.0 Action Item Review

10.0 Next Meeting and Adjournment